EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	0	((pattern with correct\$3 with mask with semiconductor) and (variable same correct\$3 same line same width same overlap\$4 same grid same misalignment)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:12
S2		((pattern with correct\$3 with mask with semiconductor) and (variable same correct\$3 same line same width same overlap\$4 same misalignment)). clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR _	ON	2007/09/17 17:11
S3	0	((variable same correct\$3 same line same width same overlap\$4 same misalignment)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:11
S4	0	((variable same line same width same overlap\$4 same misalignment)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:11
S5	0	((pattern with correct\$3 with mask with semiconductor) and (line same width same overlap\$4)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON.	2007/09/17 17:21
S6	24296	382/144,145,147.ccls. 438/16,401, 462,800.ccls. 716/2,19,20,21.ccls. 356/237.4,237.5,394.ccls. 430/4,5,30. ccls. 700/96,97,105,120,121.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2007/09/18 11:58
S7	373	((pattern with mask) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same overlap\$4))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:31

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CO		66 1 67	HC DCDHB	OB	014	2007/00/47 47 57
S8	82	S6 and S7	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:27
S9	4484	((semiconductor or wafer or mask or IC) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same overlap\$4))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:33
S10	100	S6 and S9	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:31
S11	119	((semiconductor or wafer or mask or IC) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same overlap\$4 same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:35
S12	4	S6 and S11	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:35
S13		((pattern with mask) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same overlap\$4 same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR ·	ON	2007/09/17 17:36
S14		((pattern with mask) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same width same overlap\$4 same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2007/09/17 17:35

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S15	35	((pattern with mask) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same (overlap\$4 or join\$3 or connect\$3 or overlay\$3 or intersect\$3) same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2007/09/17 17:37
S16	774	((semiconductor or wafer or mask or IC) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same (overlap\$4 or join\$3 or connect\$3 or overlay\$3 or intersect\$3) same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR .	ON .	2007/09/17 17:38
S17	8	S6 and S16	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:38



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1. Driving spectral resolution to the noise limit in semiconductor gamma de

Lachish, U.;

Nuclear Science, IEEE Transactions on

Volume 48, Issue 3, Part 1, June 2001 Page(s):520 - 523

Digital Object Identifier 10.1109/23.940110

AbstractPlus | References | Full Text: PDF(76 KB) IEEE JNL

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2. Driving spectral resolution to the noise limit in semiconductor gamma de

Lachish, U.;

Nuclear Science Symposium Conference Record, 2000 IEEE

Volume 2, 15-20 Oct. 2000 Page(s):9/175 - 9/178 vol.2 Digital Object Identifier 10.1109/NSSMIC.2000.949893

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Inventor Name Search Result

Your Search was:

Last Name = HASHIMOTO

First Name = KOJI

Application#	Patent#	Status	Date Filed	Title	Inventor Name	
06724592	Not Issued	161	04/18/1985	METHODS FOR PREPARATION OF OVERLAID METAL LAYERS		
06837812	Not Issued	166	03/10/1986	HIGHLY CORROSION- RESISTANT AND HIGH STRENGTH ALUMINUM ALLOYS	HASHIMOTO, KOJI	
06838651	Not Issued	166	03/11/1986	HIGHLY CORROSION- RESISTANT AMORPHOUS ALLOY	HASHIMOTO, KOJI	
<u>06844902</u>	Not Issued	166	03/27/1986	HIGHLY CORROSION- RESISTANT AMORPHOUS ALLOY	HASHIMOTO, KOJI	
06861371	4772773	150	02/18/1986	METHODS FOR PREPARATION OF OVERLAID AMORPHOUS ALLOY LAYERS	HASHIMOTO, KOJI	
06892827	4770949	150	08/04/1986	SURFACE ACTIVATED AMORPHOUS AND SUPERSATURATED SOLID SOLUTION ALLOYS FOR ELECTRODES IN THE ELECTROLYSIS OF SOLUTIONS AND THE METHOD FOR THEIR SURFACE ACTIVATION	HASHIMOTO, KOJI	
07098387	Not Issued	166	09/18/1987	SURFACE ACTIVATED SURFACE ALLOY ELECTRODES AND A PROCESS FOR PREPARING THEM	HASHIMOTO, KOJI	
07098391	4834806	150		CORROSION- RESISTANTSTROCTURE STRUCTURE COMPRISING A METALLK SURFACE AND AN SURFACE BONDED THEREEUPON	HASHIMOTO, KOJI	

07162987	07099371	4743314	150	09/21/1987	HIGHLY CORROSION- RESISTANT AMORPHOUS ALLOY OF NI-CU-TI WITH TA AND/OR NB	НАЅНІМОТО, КОЛ
RESISTANT AMORPHOUS KOJI	07162987	4877574	150	03/02/1988	FOR CONTROLLING POWER OF NATURAL CIRCULATION	
Issued ALLOYS KOJI	07183553	4880482	250	04/19/1988	RESISTANT AMORPHOUS	
AND HIGHLY ACTIVE ELECTRODE MADE OF THIS CATALYST	<u>07183981</u>	11 1	166	04/20/1988		'
Issued	07195732	4868073	150	05/16/1988	AND HIGHLY ACTIVE ELECTRODE MADE OF THIS	II
CORROSION OF A MATERIAL AGAINST HYDROCHLORIC ACID	<u>07236262</u>	fl I	161	08/23/1988	RESISTANT AND HIGH- STRENGTH ALUMINUM	II , , , II
Issued	07275642	4968363	250	11/22/1988	CORROSION OF A MATERIAL AGAINST HYDROCHLORIC	
Issued	07306264	II I	166	02/01/1989	RESISTANT AMORPHOUS	II , II
AMORPHOUS SUPERLATTICE KOJI	07339611	II I	166		HIGH CORROSION	II I
O7440592 S087401 150 11/22/1989 PROCESS FOR PREPARING POLYESTER FILAMENTARY MATERIAL O7453966 Not Issued Issued Issued Issued Issued O7454412 S030300 250 I2/21/1989 AMORPHOUS ALUMINUM HASHIMOTO, HA	07420903	5015352	150	10/13/1989	AMORPHOUS SUPERLATTICE	
POLYESTER FILAMENTARY MATERIAL O7453966 Not Issued	07420930	5076865	250	10/13/1989		
Issued SURFACE ALLOY ELECTRODES AND A PROCESS FOR PREPARING THEM 07454412 5030300 250 12/21/1989 AMORPHOUS ALUMINUM HASHIMOTO,	07440592	5087401	150	11/22/1989	POLYESTER FILAMENTARY	II ' II
	07453966		161	12/20/1989	SURFACE ALLOY ELECTRODES AND A PROCESS	11 ' 11
	07454412	5030300	250	12/21/1989		

<u>07481718</u>	4964967	150	02/16/1990	SURFACE ACTIVATED ALLOY ELECTRODES AND PROCESS FOR PREPARING THEM	HASHIMOTO, KOJI
07529727	Not Issued	161	05/23/1990	STABILIZED SPORE-FORMING VIABLE MICROORGANISMS PREPARATION, ITS PRODUCTION AND PELLET THEREOF	HASHIMOTO, KOJI
07592368	5123980	150	10/03/1990	SPUTTER DEPOSITED AMORPHOUS TITANIUM ALUMIUN ALLOYS	НАЅНІМОТО, КОЛ
07593745	5041175	150	10/05/1990	AMORPHOUS ALUMINUM ALLOYS	НАЅНІМОТО, КОЈІ
07662283	Not Issued	161	02/28/1991	AMORPHOUS ALLOY CATALYSTS FOR CONVERSION OF CARBON DIOXIDE	НАЅНІМОТО, КОЛ
07662286	Not Issued	161	02/28/1991	AMORPHOUS ALLOY CATALYSTS FOR DECOMPOSITION OF FLONS	НАЅНІМОТО, КОЛ
<u>07758851</u>	Not Issued	161	09/12/1991	CATALYST MATERIAL AND METHOD FOR DECOMPOSITION OF CHLOROFLUOROCARBONS	HASHIMOTO, KOJI
07766064	Not Issued	166	09/27/1991	GENE DETECTION METHOD	HASHIMOTO, KOJI
07779985	Not Issued	166	10/21/1991	AMORPHOUS ALUMINUM ALLOYS	HASHIMOTO, KOJI
07830847	5264498	250	II I	POLYCARBONATE RESIN COMPOSITION	HASHIMOTO, KOJI
07853436	5468576	150		METHOD FOR MANUFACTURING EXPOSURE MASK AND THE EXPOSURE MASK	НАЅНІМОТО, КОЈІ
07856159	5326736	250	04/01/1992	AMORPHOUS ALLOY CATALYSTS FOR CONVERSION OF EXHAUST GASES TO HARMLESS GASES	НАЅНІМОТО, КОЛ
07867127	5245112	250	04/10/1992	METHOD FOR DECOMPOSITION OF CHLOROFLUORCARBONS	HASHIMOTO, KOJI
07867527	5283059	150		PROCESS FOR PRODUCING A STABILIZED STORE-FORMING VIABLE MICROORGANISMS PREPARATION CONTAINING BACILUS CEREUS	HASHIMOTO, KOJI

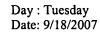
07060606	T-000105		0.44.545.55		16
07869629	5220108			AMORPHOUS ALLOY CATALYSTS FOR DECOMPOSITION OF FLONS	HASHIMOTO, KOJI
07878567	Not Issued	166	05/05/1992		HASHIMOTO, KOJI
07880047	<u>5217332</u>	150	II I	DRILL BIT FOR ADVANCED MATERIALS	HASHIMOTO, KOJI
<u>07892477</u>	Not Issued	161	06/02/1992	HIGHLY CORROSION- RESISTANT AMORPHOUS ALLOY	HASHIMOTO, KOJI
<u>07913421</u>	5248754	150	07/15/1992	PROCESS FOR CONTINUOUS PRODUCTION OF POLYCARBONATE OLIGOMER	HASHIMOTO, KOJI
07914027	5634989	150	07/15/1992	AMORPHOUS NICKEL ALLOY HAVING HIGH CORROSION RESISTANCE	HASHIMOTO, KOJI
<u>07955256</u>	5319324	150	10/01/1992	METHOD OF DIRECT BONDING OF CRYSTALS AND CRYSTAL DEVICES	HASHIMOTO, KOJI
07961783	Not Issued	166	10/15/1992	HIGH CORROSION RESISTANT AMORPHOUS ALLOYS	HASHIMOTO, KOJI
08007577	Not Issued	163	01/22/1993	HIGHLY CORROSION RESISTANT AMORPHOUS ALUMINUM ALLOY	HASHIMOTO, KOJI
<u>08008758</u>	Not Issued	163	01/25/1993	HIGHLY CORROSION RESISTANT AMORPHOUS ALUMINUM ALLOY	HASHIMOTO, KOJI
08009397	Not Issued	161		AMORPHOUS ALUMINUM ALLOYS	HASHIMOTO, KOJI
08041427	5364711	150	03/31/1993	FUEL CELL	HASHIMOTO, KOJI
08044534	Not Issued	166	04/07/1993	AMORPHOUS ALLOYS RESISTANT AGAINST HOT CORROSION	HASHIMOTO, KOJI
08073623	Not Issued	166	06/07/1993	HIGH CORROSION-RESISTANT AMORPHOUS ALLOYS	HASHIMOTO, KOJI

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Inventor Name Search Result

Your Search was:

Last Name = USUI

First Name = SATOSHI

Application#	Patent#	Status	Date Filed	Title	Inventor Name
06945298	4746536	150	12/17/1986	METHOD FOR SELECTIVE CHEMICAL PLATING	USUI, SATOSHI
<u>07987593</u>	5328541	250	12/09/1992	METHOD OF WELDING TUBULAR PRODUCTS OF POLYARYLENE SULFIDE AND WELDED TUBULAR STRUCTURE	USUI, SATOSHI
08364693	Not Issued	161	12/28/1994	APPARATUS AND METHOD FOR WELDING THERMOPLASTIC RESIN MEMBERS	USUI, SATOSHI
08365285	Not Issued	161	12/28/1994	METHOD FOR WELDING TUBULAR MEMBERS	USUI, SATOSHI
08370485	Not Issued	161	01/09/1995	APPARATUS AND METHOD FOR WELDING TUBULAR MEMBERS	USUI, SATOSHI
09137684	6136478	150	08/21/1998	MASK PATTERN CORRECTION METHOD AND EXPOSURE MASK TO BE USED FOR SUCH A METHOD	USUI, SATOSHI
<u>09155546</u>	Not Issued	164	09/25/1998	RESIN COMPOSITION	USUI, SATOSHI
09650672	<u>6526250</u>	150	08/30/2000	TRANSFER FIXING DEVICE, IMAGE BEARING AND CONVEYING BODY, AND IMAGE FORMING APPARATUS	USUI, SATOSHI
09662219	Not Issued		09/14/2000	Pattern correcting method of mask for manufacturing a semiconductor device and recording medium having recorded its pattern correcting method	
09815004	<u>6727026</u>	150	03/23/2001	SEMICONDUCTOR	USUI, SATOSHI

h ·	11 1	l	11 1	Jamaa	I
				INTEGRATED CIRCUIT PATTERNS	
09985810	6617083	150	11/06/2001	METHOD OF CORRECTING MASK PATTERNS	USUI, SATOSHI
10084386	Not Issued	164	02/28/2002	HIGH PRESSURE FUEL PUMP FOR INTERNAL COMBUSTION ENGINE	USUI, SATOSHI
10127770	6622296	150	04/23/2002	EXPOSURE MASK PATTERN CORRECTION METHOD, PATTERN FORMATION METHOD, AND A PROGRAM PRODUCT FOR OPERATING A COMPUTER	USUI, SATOSHI
10274034	7165534	150	10/21/2002	FUEL FEED SYSTEM	USUI, SATOSHI
10442203	7152583	150	05/21/2003	HIGH-PRESSURE FUEL PUMP	USUI, SATOSHI
10614206	Not Issued	161	07/08/2003	HIGH PRESSURE FUEL PUMP FOR INTERNAL COMBUSTION ENGINE	USUI, SATOSHI
10896039	7124738	150	07/22/2004	DAMPER MECHANISM AND HIGH PRESSURE FUEL PUMP	USUI, SATOSHI
10975001	Not Issued	30	10/28/2004	Image information processing system, image information processing apparatus, image information outputting method, code information processing apparatus and program thereof	USUI, SATOSHI
10975412	Not Issued	30	10/29/2004	Image outputting system, image processing apparatus, image processing method and program thereof	USUI, SATOSHI
11217444	Not Issued	61	09/02/2005	Controlling apparatus of variable capacity type fuel pump and fuel supply system	USUI, SATOSHI
11219674	Not Issued	30	09/07/2005	Index sheet, picture case, image processing apparatus, image processing method and storage medium storing program	USUI, SATOSHI
11354851	Not Issued	61	02/16/2006	Electromagnetic drive mechanism and a high-pressure fuel supply pump	USUI, SATOSHI
11409062	Not Issued	20	04/24/2006	High pressure fuel pump for internal combustion engine	USUI, SATOSHI
11546430	Not	41	10/12/2006	Damper mechanism and high	USUI, SATOSHI

	Issued	<u> </u>		pressure fuel pump	
<u>11582396</u>	Not Issued	41		High-pressure fuel supply system using variable displacement fuel pump	USUI, SATOSHI
11599468	Not Issued	25	11/15/2006	High-pressure fuel pump	USUI, SATOSHI
11622170	Not Issued	41		High pressure fuel pump provided with damper	USUI, SATOSHI
11,780940	Not Issued	17	07/20/2007	High-Pressure Fuel Pump	USUI, SATOSHI
11835544	Not Issued	19	08/08/2007	High-Pressure Fuel Supply Pump	USUI, SATOSHI

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Inventor Name Search Result

Your Search was:

Last Name = YOSHIKAWA

First Name = KEI

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>09662219</u>	Not Issued	71	09/14/2000	Pattern correcting method of mask for manufacturing a semiconductor device and recording medium having recorded its pattern correcting method	YOSHIKAWA, KEI
<u>10107298</u>	7208423	150	03/28/2002	SEMICONDUCTOR DEVICE FABRICATION METHOD AND SEMICONDUCTOR DEVICE	YOSHIKAWA, KEI
11643907	Not Issued	30	12/22/2006	Semiconductor device fabrication method and semiconductor device	YOSHIKAWA, KEI
07470028	Not Issued	166	01/25/1990	AQUEOUS RESIN COMPOSITION	YOSHIKAWA, KEIGO
07884882	Not Issued	161	05/18/1992	AQUEOUS RESIN COMPOSITION	YOSHIKAWA, KEIGO
06592588	<u>4566163</u>	150	03/23/1984	AUTOMATIC SUPERVISORY SYSTEM FOR A WARPER	YOSHIKAWA, KEIJI
07823364	5242224	150	01/21/1992	TEMPERATURE MONITORING UNIT	YOSHIKAWA, KEIJI
09763130	6452056	250	02/20/2001	PROCESS FOR THE PREPARATION OF FLUOROBENZYL DERIVATIVES	YOSHIKAWA, KEISUKE
<u>09897077</u>	<u>6756793</u>	150		CAPACITANCE TYPE MOISTURE SENSOR AND METHOD OF PRODUCING THE SAME	YOSHIKAWA, KEISUKE
10781947	7064011	150	02/20/2004	SEMICONDUCTOR DEVICE FABRICATING APPARATUS AND SEMICONDUCTOR DEVICE FABRICATING	YOSHIKAWA, KEISUKE

				METHOD	
11000905	7268191	150	12/02/2004	METHOD FOR PRODUCING EPOXY RESIN COMPOSITION FOR SEMICONDUCTOR ENCAPSULATION AND EPOXY RESIN COMPOSITION FOR SEMICONDUCTOR ENCAPSULATION AND SEMICONDUCTOR ENCAPSULATION AND SEMICONDUCTOR DEVICE OBTAINED THEREBY	YOSHIKAWA, KEISUKE
11012126	7132755	150	12/16/2004	ADHESIVE FILM FOR MANUFACTURING SEMICONDUCTOR DEVICE	YOSHIKAWA, KEISUKE
11115307	7262514	150	04/27/2005	EPOXY RESIN COMPOSITION FOR SEMICONDUCTOR ENCAPSULATION, SEMICONDUCTOR DEVICE USING THE SAME, AND PROCESS FOR PRODUCING SEMICONDUCTOR DEVICE	YOSHIKAWA, KEISUKE
11362783	Not Issued	61	02/28/2006	Semiconductor device fabricating apparatus and semiconductor device fabricating method	YOSHIKAWA, KEISUKE
11632348	Not Issued	30	·	Device and Method of Producing Them	YOSHIKAWA, KEISUKE
<u>09117599</u>	6155380	150	07/31/1998		YOSHIKAWA, KEIZO
<u>09117600</u>	Not Issued	161	07/31/1998	BEARING CLEANING DEVICE FOR ELECTRIC MOTOR	YOSHIKAWA, KEIZO

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